Application/Control No. Applicant(s)/Patent Under Reexamination 10/004,805 SHIMIZU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 A. Sefer 2826 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,501,529 12-2002 Kurihara et al. Α 349/160 US-В US-С US-D US-Ε US-F US-G USн US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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